Notice of References Cited Application/Control No. 10/705,386 Examiner Thien F. Tran Applicant(s)/Patent Under Reexamination LIU ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,232,551	05-2001	Chang, Su Yuan	174/52.4
	В	US-			
	ပ	US-			
	D	US-			
	E	US-			
	F	US-			
	O	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
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	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

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